


<b>Search Notes</b>  	<b>Application/Control No.</b>  10559538	<b>Applicant(s)/Patent Under Reexamination</b>  NAKADA ET AL.
	<b>Examiner</b>  Dinh Q Nguyen	<b>Art Unit</b>  3752

SEARCHED			
Class	Subclass	Date	Examiner
	updated search	4/11/08	DN

SEARCH NOTES		
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INTERFERENCE SEARCH			
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